

#### Description

The IRF7807PBF uses advanced trench technology to provide excellent  $R_{DS(ON)}$ , low gate charge and operation with gate voltages as low as 4.5V. This device is suitable for use as a Battery protection or in other Switching application.

#### **General Features**

V<sub>DS</sub> = 30V I<sub>D</sub> =8.5A

 $R_{DS(ON)}$  < 18m $\Omega$  @ V<sub>GS</sub>=10V

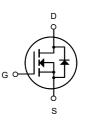
#### Application

Battery protection

Load switch Uninterruptible power supply



SOP-8



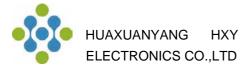
N-Channel MOSFET

### Package Marking and Ordering Information

| Product ID | Pack  | Brand      | Qty(PCS) |
|------------|-------|------------|----------|
| IRF7807PBF | SOP-8 | HXY MOSFET | 3000     |

## Absolute Maximum Ratings (T\_A = 25 $^\circ C$ unless otherwise noted)

| Symbol                               | Parameter  | Rating                                    | Units |  |
|--------------------------------------|--|---|-------|--|
| Vds                                  | Drain-Source Voltage                             | 30  | V     |  |
| Vgs                                  | Gate-Source Voltage                              | Gate-Source Voltage ±20                   |       |  |
| I <sub>D</sub> @T <sub>A</sub> =25°C | Continuous Drain Current <sup>1</sup>            | Continuous Drain Current <sup>1</sup> 8.5 |       |  |
| I <sub>D</sub> @T <sub>A</sub> =70°C | Continuous Drain Current <sup>1</sup>            | Continuous Drain Current <sup>1</sup> 5.6 |       |  |
| Ідм                                  | Pulsed Drain Current <sup>2</sup>                | Pulsed Drain Current <sup>2</sup> 35      |       |  |
| EAS                                  | Single Pulse Avalanche Energy <sup>3</sup>       | e Pulse Avalanche Energy <sup>3</sup> 20  |       |  |
| las                                  | Avalanche Current                                | Avalanche Current 20                      |       |  |
| P <sub>D</sub> @T <sub>A</sub> =25°C | Total Power Dissipation <sup>4</sup>             | 1.5                                       | W     |  |
| Тѕтс                                 | Storage Temperature Range                        | -55 to 150                                | °C    |  |
| TJ                                   | Operating Junction Temperature Range             | -55 to 150                                | °C    |  |
|                                      | Thermal Resistance Junction-ambient¹(t≤10s)      | 85  | °C/W  |  |
| R <sub>0</sub> JA                    | Thermal Resistance Junction-ambient <sup>1</sup> | 25  | °C/W  |  |



| Symbol   | Parameter                                      | Conditions  | Min.                                   | Тур.  | Max.  | Unit  |  |
|--|--|---|--|-------|-------|-------|--|
| BV <sub>DSS</sub>                                    | Drain-Source Breakdown Voltage                 | V <sub>GS</sub> =0V , I <sub>D</sub> =250uA                       | 30                                     |       |       | V     |  |
| $\triangle BV_{\text{DSS}} / \triangle T_{\text{J}}$ | BVDSS Temperature Coefficient                  | Reference to 25°C,I₀=1mA  |  | 0.034 |       | V/°C  |  |
| R <sub>DS(ON)</sub>                                  | Static Drain-Source On-Resistance <sup>2</sup> | V <sub>GS</sub> =10V , I <sub>D</sub> =7A                         | 14         18            20         26 |       |       |       |  |
|  | Static Drain-Source On-Resistance-             | V <sub>GS</sub> =4.5V , I <sub>D</sub> =4A                        |  |       | 26    | mΩ    |  |
| $V_{GS(th)}$   | Gate Threshold Voltage                         |   | 1.2                                    | 1.5   | 2.5   | V     |  |
| $	riangle V_{GS(th)}$                                | V <sub>GS(th)</sub> Temperature Coefficient    | ──V <sub>GS</sub> =V <sub>DS</sub> , I <sub>D</sub> =250uA        |  | -3.84 |       | mV/°C |  |
|  | Drain-Source Leakage Current                   | V <sub>DS</sub> =24V , V <sub>GS</sub> =0V , T <sub>J</sub> =25°C |  |       | 1     | uA    |  |
| IDSS   |  | V <sub>DS</sub> =24V , V <sub>GS</sub> =0V , T <sub>J</sub> =55°C |  |       | 5     |       |  |
| lgss   | Gate-Source Leakage Current                    | V <sub>GS</sub> =±20V , V <sub>DS</sub> =0V                       |  |       | ±100  | nA    |  |
| gfs  | Forward Transconductance                       | V <sub>DS</sub> =5V , I <sub>D</sub> =7A                          |  | 6.2   |       | S     |  |
| R <sub>g</sub>                                       | Gate Resistance                                | V <sub>DS</sub> =0V , V <sub>GS</sub> =0V , f=1MHz                |  | 1.04  | 2.1   | Ω     |  |
| Qg   | Total Gate Charge (4.5V)                       |   |  | 6     | 8.4   |       |  |
| Q <sub>gs</sub>                                      | Gate-Source Charge                             | V <sub>DS</sub> =15V , V <sub>GS</sub> =4.5V , I <sub>D</sub> =7A |  | 2.2   | 3.1   | nC    |  |
| $Q_{gd}$   | Gate-Drain Charge                              |   |  | 2     | 2.8   |       |  |
| T <sub>d(on)</sub>                                   | Turn-On Delay Time                             |   |  | 1.2   | 2.4   |       |  |
| Tr   | Rise Time                                      | $V_{DD}$ =15V , $V_{GS}$ =10V , $R_G$ =3.3 $\Omega$               |  | 40    | 72.0  | - ns  |  |
| T <sub>d(off)</sub>                                  | Turn-Off Delay Time                            | I <sub>D</sub> =7A  |  | 18    | 36.0  |       |  |
| T <sub>f</sub>                                       | Fall Time                                      |   |  | 7.2   | 14.4  |       |  |
| Ciss   | Input Capacitance                              |   |  | 583   | 816.2 |       |  |
| Coss   | Output Capacitance                             | V <sub>DS</sub> =15V , V <sub>GS</sub> =0V , f=1MHz               |  | 77    | 107.8 | pF    |  |
| C <sub>rss</sub>                                     | Reverse Transfer Capacitance                   |   |  | 59    | 82.6  |       |  |
| ls   | Continuous Source Current <sup>1,5</sup>       |   |  |       | 7     | А     |  |
| lsм  | Pulsed Source Current <sup>2,5</sup>           | ──V <sub>G</sub> =V <sub>D</sub> =0V , Force Current              |  |       | 35    | Α     |  |
| $V_{\text{SD}}$                                      | Diode Forward Voltage <sup>2</sup>             | V <sub>GS</sub> =0V , I <sub>S</sub> =1A , T <sub>J</sub> =25°C   |  |       | 1.2   | V     |  |
| t <sub>rr</sub>                                      | Reverse Recovery Time                          |   |  | 7.2   |       | nS    |  |
| Qrr  | Reverse Recovery Charge                        | I⊧=7A , dI/dt=100A/µs , Tյ=25°C                                   |  | 2.9   |       | nC    |  |

## Electrical Characteristics (TJ=25 °C, unless otherwise noted)

Note :

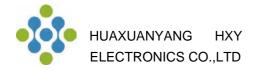
1. The data tested by surface mounted on a 1 inch<sup>2</sup> FR-4 board with 2OZ copper.

2.The data tested by pulsed , pulse width  $\leq$  300us , duty cycle  $\leq$  2%

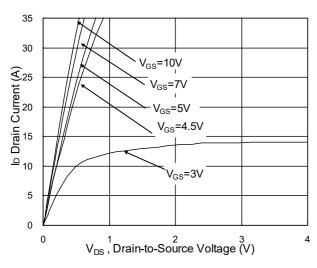
3. The EAS data shows Max. rating . The test condition is  $V_{DD}$ =25V,  $V_{GS}$ =10V, L=0.1mH, I<sub>AS</sub>=20A

4.The power dissipation is limited by 150°C junction temperature

5. The data is theoretically the same as  $I_D$  and  $I_{DM}$ , in real applications, should be limited by total power dissipation.



## **Typical Characteristics**



**Fig.1 Typical Output Characteristics** 

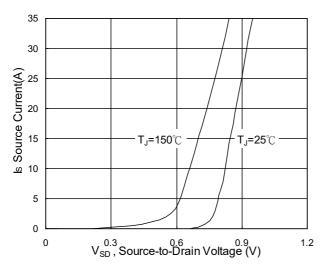


Fig.3 Forward Characteristics Of Reverse

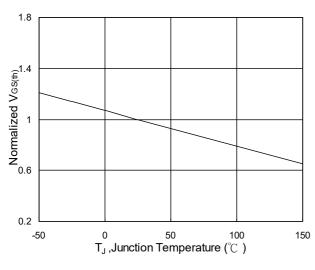


Fig.5 Normalized  $V_{\text{GS}(\text{th})}$  vs.  $T_{\text{J}}$ 

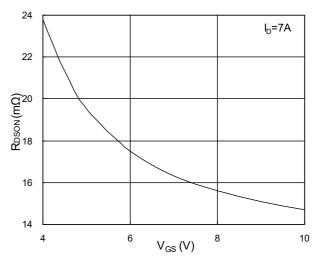


Fig.2 On-Resistance vs. Gate-Source

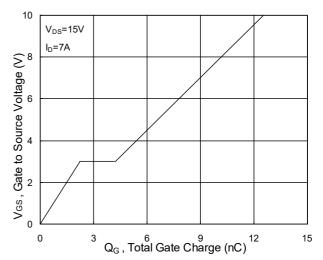


Fig.4 Gate-Charge Characteristics

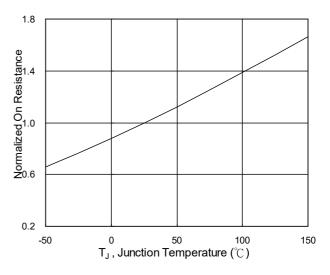


Fig.6 Normalized R<sub>DSON</sub> vs. T<sub>J</sub>



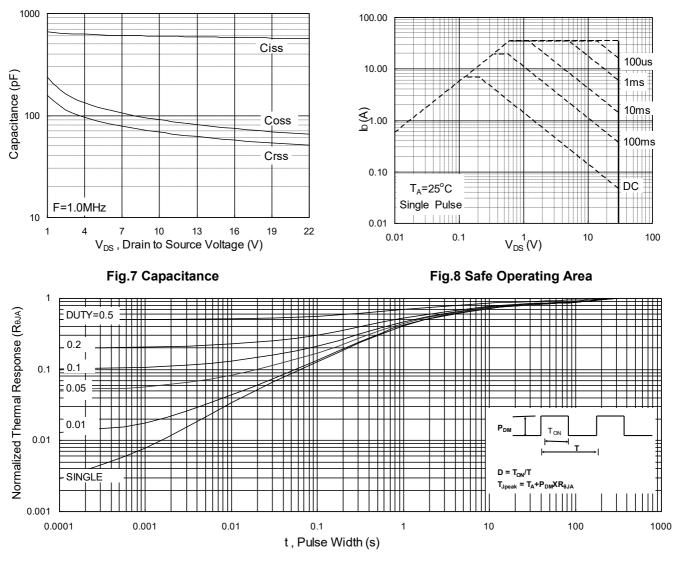


Fig.9 Normalized Maximum Transient Thermal Impedance

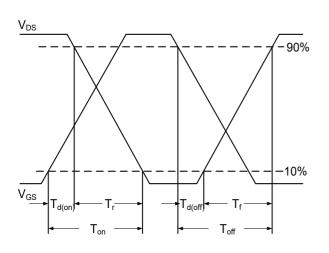


Fig.10 Switching Time Waveform

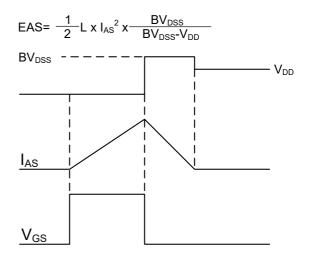
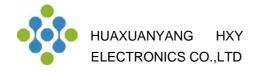
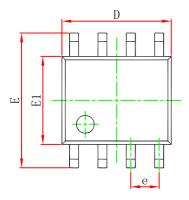
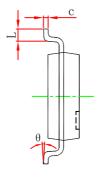


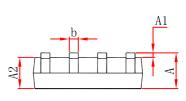
Fig.11 Unclamped Inductive Switching Waveform



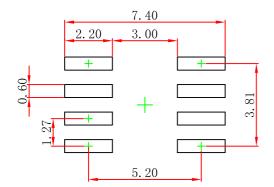
## SOP-8 Package Outline Dimensions







| Symbol | Dimensions In Millimeters |       | Dimensions In Inches |       |  |
|--------|---------------------------|-------|----------------------|-------|--|
|        | Min                       | Max   | Min                  | Max   |  |
| Α      | 1.350                     | 1.750 | 0.053                | 0.069 |  |
| A1     | 0.100                     | 0.250 | 0.004                | 0.010 |  |
| A2     | 1.350                     | 1.550 | 0.053                | 0.061 |  |
| b      | 0.330                     | 0.510 | 0.013                | 0.020 |  |
| с      | 0.170                     | 0.250 | 0.007                | 0.010 |  |
| D      | 4.800                     | 5.000 | 0.189                | 0.197 |  |
| e      | 1.270 (BSC)               |       | 0.050 (BSC)          |       |  |
| E      | 5.800                     | 6.200 | 0.228                | 0.244 |  |
| E1     | 3.800                     | 4.000 | 0.150                | 0.157 |  |
| L      | 0.400                     | 1.270 | 0.016                | 0.050 |  |
| θ      | 0 °                       | 8°    | 0 °                  | 8°    |  |



Note: 1.Controlling dimension: in millimeters.

2.General tolerance:± 0.05mm.
 3.The pad layout is for reference purposes only.



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